

**Search Notes**

Application/Control No.

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Examiner

Than Nguyen

Applicant(s)/Patent under  
Reexamination

TAKASE ET AL.

Art Unit

2187

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
711	103	8/28/2007	NTV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Update West search Inventor IEEE	8/28/2007	NTV